Application/Control No. Applicant(s)/Patent Under Reexamination 10/540,728 TAKAHASHI ET AL. **Notice of References Cited** Examiner Art Unit Page 1 of 1 MUHAMMAD N. EDUN 2627

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-7,023,775	04-2006	Ito et al.	369/47.55
	В	US-			
	С	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	K	US-			
£	L	US-			
	М	US-	5		

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

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